

Application Serial No. 10/773,524  
Response to Office Action

Customer No. 01933

Attorney Docket No. 04083/LH

**IN THE UNITED STATES PATENT  
AND TRADEMARK OFFICE**

Applicant(s) : Takashi YONEYAMA, et al.

Serial No. : 10/773,524

Confirm. No.: 7190

Filed : February 6, 2004

For : DEFECT INSPECTION APPARATUS AND  
DEFECT INSPECTION METHOD

Art Unit : 2624

Examiner : Tsung Yin Tsai

This paper is being submitted via  
EFS-Web on September 29, 2009

In the event that this Paper is late filed, and the necessary petition for extension of time is not filed concurrently herewith, please consider this as a Petition for the requisite extension of time, and to the extent not already paid, authorization to charge the extension fee to Account No. 06-1378. In addition, authorization is hereby given to charge any fees for which payment has not been submitted, or to credit any overpayments, to Account No. 06-1378.

**A M E N D M E N T**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

S I R :

This is responsive to the Office Action mailed July 6, 2009,  
the term for response to which expires on October 6, 2009.

**Amendments to the Claims** are set forth in the listing of claims which begins on page 2 of this paper. Claims 1, 5-8, 13-17, 19 and 23 are canceled; claims 9 and 18 are amended; and claims 2-4, 10-12, 20-22 and 24-26 are maintained.

**Remarks** begin on page 11 of this paper.